

Notice of References Cited	Application/Control No. 10/724,209	Applicant(s)/Patent Under Reexamination ADLER, JON ELLIOT	
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X	U	Bowie et al., 1990, Science 247:1306-1310
X	V	Guo-HH et al. PNAS 101(25)9205-9210, 2004
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X	X	Hoon et al., Cell 96(541-551)1999

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